


<b>Search Notes</b>  	<b>Application/Control No.</b>  10616067	<b>Applicant(s)/Patent Under Reexamination</b>  YANO ET AL.
	<b>Examiner</b>  Foud, Hicham B	<b>Art Unit</b>  2419

SEARCHED			
Class	Subclass	Date	Examiner
370	318,332	1/26/2009	HF
370	333	1/26/2009	HF
455	522	1/26/2009	HF

SEARCH NOTES		
Search Notes	Date	Examiner
UPDATE EAST SEARCH	1/26/2009	HF
Text search	1/26/2009	HF
Google search	1/26/2009	HF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search (see east printout)	1/26/2009	hf

/HICHAM B FOUD/ Examiner.Art Unit 2419	
---	--